

**Search Notes**

Application/Control No.

10/826,509

Examiner

Fred I. Ehichioya

Applicant(s)/Patent under  
Reexamination

BAILEY ET AL.

Art Unit

2162

**SEARCHED**

Class	Subclass	Date	Examiner
707	2, 3, 5, 8, 100, 101, 103R, 20	12/31/2006	FE
709	170	12/31/2006	FE
711	201, 213	12/31/2006	FE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
ACM Search	9/30/2006	FE
IEEE Xplore	9/30/2006	FE
Inventor Name Search	12/31/2006	FE
East	12/31/2006	FE